

Search Notes**Application/Control No.**

10/571,281

Examiner

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**Applicant(s)/Patent under
Reexamination**

MAKUTH ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
336	115-118, 130-135, 200,225, 229	3/27/2009	TN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR